

# Distribution-free bounds for serial correlation coefficients <sup>\*</sup>

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## ABSTRACT

We consider the problem of testing whether the observations  $X_1, \dots, X_n$  of a time series are independent with unspecified (possibly nonidentical) distributions symmetric about a common known median. Various bounds on the distributions of serial correlation coefficients are proposed : exponential bounds, Eaton-type bounds, Chebyshev bounds and Berry-Esséen-Zolotarev bounds. The bounds are exact in finite samples, distribution-free and easy to compute. The results are applied to U.S. data on interest rates.

Key words : autocorrelation; nonparametric test; distribution-free test; heteroskedasticity; interest rates; robustness.

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# 1. Introduction

Let  $X_1, X_2, \dots, X_n$  be a time series of length  $n$ . In many situations, it is of interest to test whether the  $X_t$ 's are independent against an alternative of serial dependence, say, at lag  $k$  ( $k \geq 1$ ). If under the null hypothesis the observations are assumed to be identically distributed with known means  $\mu_t$ , a natural test consists in rejecting the null hypothesis for large or small values of the autocorrelation coefficient

$$r_k = \sum_{t=1}^{n-k} (X_t - \mu_t) (X_{t+k} - \mu_{t+k}) / \sum_{t=1}^n (X_t - \mu_t)^2, \quad (1.1)$$

where  $1 \leq k \leq n-1$ . Under general regularity conditions, the distribution of  $r_k$  is approximately normal with mean zero and variance  $n^{-1}$ ; see Anderson (1971, chapter 8) or Brockwell and Davis (1991, chapter 7).

When the observations are not identically distributed, such a procedure can clearly be inappropriate. In this paper, we study the null hypothesis  $H_0$  under which the observations  $X_1, \dots, X_n$  are independent but possibly nonidentically distributed, with distributions symmetric about known medians  $\mu_t$ . No assumption about the existence of the moments of  $X_1, \dots, X_n$  is made, and the distribution of the observations can be discrete. Without loss of generality, we can assume that  $\mu_1 = \dots = \mu_n = 0$ , and we henceforth set  $\mu_t = 0$ ,  $t = 1, \dots, n$ .

The hypothesis  $H_0$  is “nonparametric” in the sense that no finite-dimensional parameter vector can determine entirely the probability distribution of the observations  $X_1, X_2, \dots, X_n$ . Following standard terminology [see Lehmann (1986, sections 3.1 and 3.5)], a test of  $H_0$  has *level*  $\alpha$  if the probability of rejecting  $H_0$  is *not greater than*  $\alpha$  under any distribution of  $X = (X_1, \dots, X_n)'$  included in  $H_0$  ( $0 < \alpha < 1$ ). If moreover the supremum of the rejection probabilities over  $H_0$  is equal to  $\alpha$ , one says that the test has *size*  $\alpha$ . Since  $H_0$  covers a wide variety of probability distributions and because of the “parametric origin” of the coefficient  $r_k$ , the distribution of  $r_k$  under  $H_0$  depends on the *form* of the distribution of the observations. Without additional assumptions, it is unknown. Consequently, no *similar* critical region of the type  $|r_k| > c$  (where  $c$  is a nonstochastic critical point which depends on the level of the test) does exist: *i.e.*, for  $0 < c < 1$ , the probability of the event  $|r_k| > c$  is not constant over the set of data generating processes (DGP) in  $H_0$ , and finding a valid critical value involves bounding the distribution of  $r_k$  over  $H_0$  or considering data-dependent critical regions for  $r_k$ . In particular, there is strictly no guarantee that the actual sizes of tests based on the asymptotic (normal) distribution of  $r_k$  will be less than or equal to their nominal level (as tests of  $H_0$ ) in finite samples. The same will hold *a fortiori* for critical values obtained under parametric assumptions, *e.g.*, the assumption that  $X_1, \dots, X_n$  are independent and identically distributed (i.i.d.) random variables according to  $N(0, \sigma^2)$  distribution [in which case exact critical values may be computed using Imhof’s algorithm]: such critical values – though they belong to daily practice – simply do not yield valid tests of the nonparametric hypothesis  $H_0$ .

The objective of this paper is to develop *finite-sample* ( $\alpha$ -level) tests based on  $r_k$  for the *nonparametric null hypothesis*  $H_0$ . In other words, we need to ensure that the probability of rejecting  $H_0$  is not greater than  $\alpha$  under any DGP in  $H_0$ . This problem is quite distinct from the one where one tries to approximate the distribution of  $r_k$  under some *specific* distribution included in  $H_0$  (like the i.i.d. Gaussian model). Following a classic nonparametric technique, we shall do this here by using

an appropriate *conditioning*. When  $X_1, X_2, \dots, X_n$  are absolutely continuous, the vector of absolute values  $|X| = (|X_1|, \dots, |X_n|)'$  is a complete sufficient statistic for  $H_0$ . Further, classical arguments of similarity and Neyman structure lead one to consider tests that are conditional with respect to the complete sufficient statistic  $|X|$ ; see Lehmann (1986, chapter 4). The conditional distribution of  $X = (X_1, X_2, \dots, X_n)'$  given  $|X|$  is then determined by the distribution of the signs of  $X_1, \dots, X_n$ . Since, under  $H_0$ , the signs are independent symmetric Bernoulli variables, the conditional distribution of  $r_k$  (given the vector of absolute values  $|X|$ ) may in principle be computed, *e.g.*, by enumeration. In practice, however, the conditional distribution of  $r_k$  depends on each specific sample, because it is a function of  $|X|$ , and so finding critical values may be difficult. This problem is also met in the well-known case of permutation  $t$ -tests; see Pratt and Gibbons (1981, chapter 4).

For the problem of testing  $H_0$  against location-shift alternatives, simple bounds for the conditional and unconditional distributions of the  $t$ -statistic were provided in Edelman (1986, 1990) and Dufour and Hallin (1991, 1993); similar bounds for general linear signed rank statistics have also been proposed in Dufour and Hallin (1992). Beyond the important advantage of exactness for any sample size, extensive comparisons in Dufour and Hallin (1991, 1992, 1993) indicate that the bounds studied (exponential, Chebyshev-type, Eaton-type, Berry-Esséen) can be surprisingly tight, especially if one takes the minimum of the various bounds.

In this paper, we give analogous results for tests of  $H_0$  based on  $r_k$  against serial dependence alternatives. Four types of bounds are presented: (1) exponential bounds (Proposition 2.1); (2) improved Eaton bounds (Proposition 3.1); (3) Chebyshev-type bounds (Proposition 3.2); (4) Berry-Esséen-Zolotarev bounds (Proposition 4.1). The exponential bounds are based on the conditional moment generating function of  $r_k$  (given  $|X|$ ), the improved Eaton and Chebyshev-type bounds on conditional moments of  $r_k$  (a truncated third moment in the case of the Eaton bound), while the Berry-Esséen-Zolotarev bound is based on the normal distribution function. The exponential, Eaton, Chebyshev and Berry-Esséen bounds extend to the case of autocorrelation coefficients the bounds proposed in Dufour and Hallin (1991, 1992, 1993).

All these bounds are exact in finite samples and simple to compute. They are applicable despite the presence of general forms of nonnormality and heteroskedasticity (provided the symmetry hypothesis holds). In particular, no assumption about the existence of moments is required, and the variables considered may have continuous or discrete distributions. None of the bounds given uniformly dominates the others. While the three first classes of bounds are especially useful to obtain upper bounds for small tail areas, the Berry-Esséen bounds can be tighter for larger tail areas (*i.e.*, tails associated with points that are closer to the center of the distribution) and yield lower bounds on tail areas as well. Conservative conditional (given  $|X|$ ) as well as unconditional conservative  $p$ -values, or critical points, for tests based on  $r_k$  can be obtained from any one of these bounds. Since all the bounds are simple to compute, the obvious strategy here is to take the smallest  $p$ -value yielded by the different bounds (or, equivalently, the tightest critical point). Such  $p$ -values provide a useful nonparametric check on the significance of tests based on autocorrelation coefficients.

The exponential bounds are described in section 2, the Eaton and Chebyshev bounds are given in section 3, while the Berry-Esséen bounds are derived in section 4. In section 5, simulation results on the performance of the bounds are presented. In section 6, we illustrate the use of the bounds by

applying them to data on commercial paper interest rates in the U.S.

## 2. Exponential bounds

In the following proposition, we derive exponential bounds for the tail areas of the conditional distributions of  $r_k$  given  $|X|$  under the null hypothesis that  $X_1, \dots, X_n$  are independent with distributions symmetric about zero. The proofs of the propositions appear in Appendix A.

**Proposition 2.1** EXPONENTIAL BOUNDS. *Let  $X_1, \dots, X_n$  be independent random variables with distributions symmetric about zero,  $|X| = (|X_1|, \dots, |X_n|)'$ , and*

$$r_k = \sum_{t=1}^{n-k} X_t X_{t+k} / \sum_{t=1}^n X_t^2, \quad 1 \leq k \leq n-1, \quad (2.1)$$

$$w_{kt} = |X_t X_{t+k}| / \left( \sum_{\tau=1}^{n-k} X_\tau^2 X_{\tau+k}^2 \right)^{\frac{1}{2}}, \quad t = 1, \dots, n-k, \quad (2.2)$$

where we use the convention  $0/0 = 0$ . Then the conditional distribution of  $r_k$  given  $|X|$  is symmetric about zero and, for all  $y > 0$  and  $1 \leq k \leq n-1$ ,

$$\begin{aligned} \mathbb{P}[r_k \geq y \mid |X|] &\leq B_k(y_k, |X|) \leq \exp(-y_k^2) \prod_{t=1}^{n-k} \cosh(w_{kt} y_k) \\ &\leq \exp(-y_k^2) [\cosh(y_k / \sqrt{n_k^*})]^{n_k^*} \leq \exp(-y_k^2 / 2), \end{aligned} \quad (2.3)$$

where  $y_k = y/D_k(|X|)$ ,  $\cosh(x) = (e^x + e^{-x})/2$ ,  $n_k^* = \text{card}(\{t : |X_t X_{t+k}| \neq 0, 1 \leq t \leq n-k\})$  is the number of products  $X_t X_{t+k}$  different from zero,

$$\begin{aligned} D_k(|X|) &= \left( \sum_{t=1}^{n-k} X_t^2 X_{t+k}^2 \right)^{\frac{1}{2}} / \left( \sum_{t=1}^n X_t^2 \right), \\ B_k(y, |X|) &= \inf_{z \geq 0} \left\{ \exp(-zy) \prod_{t=1}^{n-k} \cosh(w_{kt} z) \right\} \end{aligned}$$

and the four bounds in (2.3) are set equal to zero when  $D_k(|X|) = 0$ .

From the symmetry of the conditional distribution of  $r_k$ , it is clear that  $\mathbb{P}[|r_k| \geq y \mid |X|] = 2\mathbb{P}[r_k \geq y \mid |X|] = 2\mathbb{P}[r_k \leq -y \mid |X|]$ , so that (2.3) can also be used to bound  $\mathbb{P}[r_k \leq -y]$  and  $\mathbb{P}[|r_k| \geq y \mid |X|]$  for any  $y > 0$ . In (2.3), four bounds on the tail areas  $\mathbb{P}[r_k \geq y \mid |X|]$  are given. Denote them by  $E_{1k} \leq E_{2k} \leq E_{3k} \leq E_{4k}$  in ascending order. These bounds are increasingly looser, but the larger ones are easier to compute. In particular,  $E_{2k}$ ,  $E_{3k}$  and  $E_{4k}$  only require

information about the second empirical moments of the sample ( $r_k$  and  $\sum X_t^2$ ), which may be useful when the complete observation vector  $X = (X_1, \dots, X_n)'$  is not available to an investigator. The exponential bound  $E_{4k} = \exp(-y_k^2/2)$  is similar to a bound given by Edelman (1986) and Efron (1969) for the case of  $t$ -statistics; for an earlier related result, see also Hoeffding (1963). In contrast with the case of  $t$ -statistics, however, this bound now explicitly depends on  $|X|$  through  $D_k(|X|)$ . The second largest bound  $E_{3k} = \exp(-y_k^2) [\cosh(y_k / \sqrt{n_k^*})]^{n_k^*}$  uniformly improves the latter by explicitly taking into account the sample size and the lag. It is based on a result given by Eaton (1970) for linear combinations of independent Bernoulli variables. For example, for  $n - k = 10$  and  $y_k = 3$ , we have  $E_{3k} = 0.0064$  while  $E_{4k} = 0.0111$ . Similarly, the bound  $E_{2k} = \exp(-y_k^2) \prod \cosh(w_{kt}y_k)$  improves the two previous ones by explicitly taking into account the weights  $w_{kt}$ ,  $t = 1, \dots, n-k$ . When the weights are equal, *i.e.*,  $w_{kt} = 1/\sqrt{n_k^*}$ ,  $t = 1, \dots, n-k$ , the bounds  $E_{2k}$  and  $E_{3k}$  coincide. In the other cases,  $E_{2k}$  can yield substantial improvements over  $E_{3k}$ , especially when the data contain a large outlier. For example, if  $w_{kt} \rightarrow 0$ ,  $n_k^* = 10$  and  $y_k = 3$ , the ratio  $E_{2k}/E_{3k}$  converges to 0.1933. Finally, the smallest bound  $E_{1k} \equiv B_k(y_k, |X|)$  is obtained by finding the infimum of the function  $M_k(z) = \exp(-zy_k) \prod_{t=1}^{n-k} \cosh(w_{kt}z)$  for  $z \geq 0$ .  $E_{4k}$  in turn can yield substantial improvement over the previous bounds. The function  $B_k(y, |X|)$  has the following more explicit expression :

$$\begin{aligned}
B_k(y, |X|) &= 0, & \text{if } \sum_{t=1}^{n-k} w_{kt} < y, \\
&= \left(\frac{1}{2}\right)^{n_k^*}, & \text{if } \sum_{t=1}^{n-k} w_{kt} = y, \\
&= \exp(-z_k^* y) \prod_{t=1}^{n-k} \cosh(w_{kt} z_k^*), & \text{if } \sum_{t=1}^{n-k} w_{kt} > y,
\end{aligned} \tag{2.4}$$

and  $z_k^*$  is the unique positive value of  $z$  that solves the equation

$$\sum_{t=1}^{n-k} w_{kt} \left[ (1 - e^{-2w_{kt}z}) / (1 + e^{-2w_{kt}z}) \right] = y.$$

It is fairly easy to compute  $B_k(y, |X|)$  by numerical methods; for further discussion, see Dufour and Hallin (1992, pp. 315-317).

Since they depend on  $|X|$  only through  $D_k(|X|)$ , the two largest bounds  $E_{3k}$  and  $E_{4k}$  in (2.3) also yield simple unconditional bounds : for all  $y > 0$ ,

$$P[r_k \geq y D_k(|X|)] \leq \exp(-y^2) \left[ \cosh\left(y/\sqrt{n-k}\right) \right]^{n-k} \leq \exp(-y^2/2). \tag{2.5}$$

However, in most practical cases, the weights  $w_{kt}$  are known so that the better bounds  $E_{1k}$  and  $E_{2k}$  are available: conditional critical values based on the latter always yield less conservative tests (both conditionally and unconditionally).

### 3. Bounds based on moments

The exponential bounds described in Proposition 2.1 are based on the conditional moment generating function of  $r_k$ . In this section, we give two sets of bounds based on considering appropriate moments of  $r_k$ . The first one applies results from Eaton (1970), Pinelis (1991) and Dufour and Hallin (1993), and is based on minimizing a truncated third order moment. We denote by  $\varphi(y) = (2\pi)^{-1/2} \exp(-y^2/2)$  the  $N(0, 1)$  density function, and by  $(y)_+$  the positive part of any real number  $y$ , i.e.,  $(y)_+ = \max(0, y)$ .

**Proposition 3.1** IMPROVED EATON-PINELIS BOUNDS. *Under the assumptions and notations of Proposition 2.1, we have :*

$$\begin{aligned} \mathbb{P}[r_k \geq y \mid |X|] &\leq \min\{B_E(y_k; n_k^*), 0.5 y_k^{-2}, 0.5\} = B_{EP}^*(y_k; n_k^*) \\ &\leq \min\{B_E(y_k), 0.5 y_k^{-2}, 0.5\} = B_{EP}(y_k) \end{aligned} \quad (3.1)$$

for all  $y > 0$ , where

$$B_E(y; m) = (0.5) \inf_{0 \leq c < y} \left\{ (0.5)^m \sum_{j=0}^m \binom{m}{j} f_c \left[ (m/4)^{-1/2} (j - (m/2)) \right] / (y - c)^3 \right\}, \quad (3.2)$$

$f_c(x) = [(|x| - c)_+]^3$ ,  $\binom{m}{j} = m! / [j! (m - j)!]$ , and

$$\begin{aligned} B_E(y) &= \inf_{0 \leq c < y} \int_c^\infty \left( \frac{z - c}{y - c} \right)^3 \varphi(z) dz \\ &= \inf_{0 \leq c < y} \left\{ [\varphi(c) (2 + c^2) - (1 - \Phi(c)) (c^3 + 3c)] / (y - c)^3 \right\}. \end{aligned} \quad (3.3)$$

Calculation of the bounds,  $B_{EP}^*(y; m)$  and  $B_{EP}(y)$  is discussed in Dufour and Hallin (1993), where the associated (conservative) critical values for standard significance levels are also reported. It is of interest to note that the bound  $B_{EP}$  enjoys an optimality property in the sense that it is tightest among all bounds based on expectations of convex functions of a standard normal variable; see Pinelis (1991) and Dufour and Hallin (1993). Note also that the function  $B_E(y; m)$  is monotonic increasing in  $m$ , i.e.,  $B_E(y; m) \leq B_E(y; m + 1)$  for  $y > 0$ .

Another related method consists in bounding the tail areas of  $r_k$  with Chebyshev-type inequalities. As observed in Dufour and Hallin (1992), such bounds can be quite tight, especially if they are based on higher-order moments (i.e., moments of order greater than 2). We summarize these in the following proposition.

**Proposition 3.2** GENERALIZED CHEBYSHEV BOUNDS. *Let the assumptions and notations of Proposition 2.1 hold. Then, for any positive even integer  $p$  and for any  $y > 0$ ,*

$$\mathbb{P}[r_k \geq y \mid |X|] \leq \frac{E[r_k^p \mid |X|]}{2y^p} \leq \frac{D_k(|X|)^p E[Y(n_k^*)^p]}{2y^p}$$



$$\leq \left\lceil \frac{(p-1)(p-3)\cdots 3\cdot 1}{2y^p} \right\rceil D_k(|X|)^p, \quad (3.4)$$

and

$$P[r_k \geq y \mid |X|] \leq \left\lceil \frac{(p_k^* - 1)(p_k^* - 3)\cdots 3\cdot 1}{2y^{p_k^*}} \right\rceil D_k(|X|)^{p_k^*}, \quad (3.5)$$

where  $Y(m)$  refers to a  $\text{Bin}(m, 0.5)$  random variable,  $p_k^* = \max\{2, \bar{p}_k\}$  and  $\bar{p}_k$  is the largest even integer such that  $\bar{p}_k < 1 + y_k^2$ .

To implement the first bound in (3.4), we need the conditional moments of  $r_k$  given  $|X|$ . These can be established easily from (A.1), (A.2) and (A.3) in the proof of Proposition 2.1 and equations (3.2) to (3.6) in Dufour and Hallin (1992); the appropriate expressions are given in Appendix B. Even moments  $E(r_k^p \mid |X|)$  of order greater than 12 can be established by analogous methods, but the algebra is correspondingly more involved. The standardized binomial moments can be computed up to any desired order from formulae (3.8) and (3.9) in Dufour and Hallin (1992), and so the two larger bounds in (3.4) above can be obtained easily for any value of  $p$ . Clearly, the bounds in (3.4) can be computed for several values of  $p$  and the minimum of these bounds again provides a valid bound. The bound (3.5) is the explicit solution of this minimization process (over all even values of  $p \geq 2$ ) based on the third bound in (3.4), which is based on the moments of a  $N(0, 1)$  distribution.

## 4. Berry-Esséen-Zolotarev bounds

The results of the two previous sections yield *upper* bounds on the tail areas of autocorrelation coefficients under the null hypothesis of independence, and they can therefore be used to check whether we can safely reject the null hypothesis at a given level under relatively weak nonparametric assumptions. Further, these bounds are reasonably tight only when  $y$  is not too small (say,  $y > 1.5$ ). In many cases, it would also be helpful to have a *lower* bound which could be used to decide whether an autocorrelation coefficient unambiguously lies in the acceptance region of the (conditional) test based on  $r_k$ .

Unfortunately, it appears much more difficult to obtain lower bounds similar to the upper bounds previously given. In order to obtain such lower bounds as well as upper bounds whose behavior may be more satisfactory for lower values of  $y$ , we will consider bounds of the Berry-Esséen type. More precisely, in the following proposition, we combine results of van Beek (1972) and Zolotarev (1965) to bound the distance between the conditional distribution of  $r_k$  and a normal distribution.

**Proposition 4.1** BERRY-ESSÉEN-ZOLOTAREV BOUNDS. *Under the assumptions and notations of Proposition 2.1 and provided  $X_t X_{t+k} \neq 0$  for at least one  $t$  ( $1 \leq t \leq n - k$ ), we have*

$$\begin{aligned} & |P[r_k < y \mid |X|] - \Phi[y / D_k(|X|)]| \\ & \leq \Delta \equiv \min \left\{ 0.7975 \sum_{t=1}^n |w_{kt}|^3, 0.366145 \left( \sum_{t=1}^n |w_{kt}|^3 \right)^{1/4} \right\} \end{aligned}$$

$$\leq 0.366145 \quad (4.1)$$

for all  $y$ , where  $\Phi(y)$  denotes the  $N(0, 1)$  distribution function.

It is clear that inequality (4.1) can provide both upper and lower bounds on the tail areas of  $r_k$  :

$$BE_L \equiv 1 - \Phi[y / D_k(|X|)] - \Delta \leq P[r_k \geq y \mid |X|] \leq 1 - \Phi[y / D_k(|X|)] + \Delta \equiv BE_U. \quad (4.2)$$

The normal approximation is seen to be good when  $\sum |w_{kt}|^3$  is small. It also follows from (4.1) that the conditional distribution of  $r_k$  given  $|X|$  (hence also its unconditional distribution) converges to a normal distribution when  $\sum |w_{kt}|^3$  goes to zero. But, of course, the main interest of (4.1) lies in the fact that it is an operational finite-sample approximation result, not a convergence theorem.

## 5. Simulation experiment

In order to provide some evidence on the size and power of the proposed bounds, we considered an AR(1) process of the form:

$$X_t = \rho X_{t-1} + u_t, \quad t = 1, \dots, n, \quad (5.1)$$

$$u_t = d_t v_t, \quad t = 1, \dots, n, \quad (5.2)$$

where the variables  $v_t$ ,  $t = 1, \dots, n$ , are i.i.d., the  $d_t$ 's are scale parameters which determine the form of the heteroskedasticity, and  $X_t = 0$  (fixed). Two types of distributions for  $v_t$  were considered:

$$(G) \quad v_t \stackrel{i.i.d.}{\sim} N(0, 1), \quad t = 1, \dots, n, \quad (5.3)$$

$$(C) \quad v_t \stackrel{i.i.d.}{\sim} Cauchy, \quad t = 1, \dots, n. \quad (5.4)$$

For the error heterogeneity, the patterns described in Table 1 were studied.

The results of the simulations are reported in Tables 2 - 4. In these tables, the statistics  $|t(r_1)|$ ,  $|\tilde{t}(r_1)|$ ,  $|t(\hat{\rho}_k)|$  and  $|\bar{t}(\hat{\rho}_k)|$  represent four alternative ways of standardizing standard (parametric) autocorrelation coefficients while  $E_{11}$  represents the best exponential bound. The autocorrelation statistics are:

$$|t(r_k)| = |\sqrt{n} r_k|, \quad |\tilde{t}(r_k)| = |r_k / \sigma_k|, \quad (5.5)$$

$$|t(\hat{\rho}_k)| = |\sqrt{n} \hat{\rho}_k|, \quad |\bar{t}(\hat{\rho}_k)| = |(\hat{\rho}_k - \mu_k) / \sigma_k|, \quad (5.6)$$

where  $r_k$  is defined in (2.1),

$$\hat{\rho}_k = \sum_{t=1}^{n-k} (X_t - \bar{X})(X_{t+k} - \bar{X}) / \sum_{t=1}^n (X_t - \bar{X})^2 \quad (5.7)$$

is the usual “centered” autocorrelation coefficient, while  $\mu_k = -(n - k) / [n(n + 1)]$  and  $\sigma_k^2 =$

Table 1. Heteroskedasticity patterns studied

	Type	
M1	Homoskedasticity	$d_t = 1, \quad t = 1, \dots, n$
M2	One outlier I	$d_t = 10, \quad \text{if } t = n/2$ $= 1, \quad \text{otherwise}$
M3	One outlier II	$d_t = 100, \quad \text{if } t = n/2$ $= 1, \quad \text{otherwise}$
M4	Exponential I	$d_t = e^{t/10}, \quad t = 1, \dots, n$
M5	Exponential II	$d_t = e^{t/2}, \quad t = 1, \dots, n$
M6	Two outliers I	$d_t = 10, \quad \text{if } t = \frac{n}{2} \text{ or } \frac{n}{2} + 1$ $1, \quad \text{otherwise}$
M7	Two outliers II	$d_t = 100, \quad \text{if } t = \frac{n}{2} \text{ or } \frac{n}{2} + 1$ $1, \quad \text{otherwise}$
M8	Two outliers III	$d_t = 10^6, \quad \text{if } t = \frac{n}{2} \text{ or } \frac{n}{2} + 1$ $1, \quad \text{otherwise}$

$(n - k)/[n(n + 2)]$  are the adjusted mean and variance suggested in Dufour and Roy (1985) for the case of a sequence of i.i.d. observations.

For each of the above parametric statistics, we also report the results of tests based on four ways of computing critical values: (1) standard asymptotic normal critical values; (2) critical points based on the Imhof algorithm assuming the observations are i.i.d. Gaussian (the Imhof critical values were also cross-checked by simulation); (3) critical values obtained by simulation under each specific distribution and heteroskedasticity pattern considered; (4) critical values based on the largest critical that we could find over the different null hypotheses considered. Of course, the second method is best choice under the assumption made by the Imhof algorithm, but will not correct the level under the other independence models (e.g., with heteroskedasticity). The third method provides a theoretical benchmark that cannot be achieved in practice, because the heteroskedasticity pattern is typically unknown in practice. The fourth method is the one closest to what one would like to do to obtain a distribution-free tests that is robust to non-normality and heteroskedasticity of unknown form, based on these statistics. It is not clear, however, that the (marginal) distributions of these statistics under the null hypothesis can be bounded in a useful way under the (very wide) hypotheses considered by the conditional bound procedures we propose [for further of discussion of this point, see Pratt and Gibbons (1981, chapter 4), Dufour and Hallin (1991, section 1), Dufour (2003, section 4.2)]. We do not have a way of producing provably valid critical values for these tests. So the “size-corrected” critical values used for the unconditional tests remain too , “small” and the powers presented overestimate the true power of these procedures for the nonparametric null hypothesis studied.

All the tests are performed at the 0.05 nominal level. Sample sizes  $n = 30, 60$  were considered.

Table 2. Empirical levels of alternative tests for serial dependence at nominal level  $\alpha = 0.05$

Sample size: $n = 30$		Asymptotic tests and bounds									
Error distribution ( $v_t$ )		N(0, 1)					Cauchy				
Heteroskedasticity type		M1	M2	M5	M7	M8	M1	M2	M5	M7	M8
$ t(r_1) $		3.90	1.67	33.33	49.96	50.49	2.47	2.43	17.57	24.15	33.96
$ \tilde{t}(r_1) $		4.96	2.20	35.82	52.78	53.31	2.95	2.88	19.21	26.34	36.06
$ t(\hat{\rho}_k) $		4.22	1.91	31.71	47.21	47.76	2.43	2.32	16.68	22.52	32.00
$ \tilde{t}(\hat{\rho}_k) $		4.65	2.17	34.22	50.50	51.09	2.88	2.62	18.28	24.44	34.35
$E_{11}$		0.95	0.87	2.10	0.77	0.00	1.10	1.33	2.94	1.70	0.00
Best bound		1.11	1.00	2.10	0.78	0.00	1.16	1.36	2.94	1.70	0.00
Tests based on Imhof critical values											
$ t(r_1) $		5.09	2.30	36.25	53.20	53.88	3.04	2.96	19.50	26.68	36.48
$ \tilde{t}(r_1) $		5.45	2.49	36.99	54.05	54.77	3.21	3.17	19.92	27.17	37.20
$ t(\hat{\rho}_k) $		5.57	2.53	34.60	50.82	51.68	2.95	3.10	18.50	25.35	35.06
$ \tilde{t}(\hat{\rho}_k) $		5.20	2.47	35.49	51.98	52.53	3.08	2.82	19.14	25.78	35.39
Tests based on global size correction											
$ t(r_1) $		0.01	0.00	4.67	0.00	0.00	0.03	0.00	1.42	0.13	0.00
$ \tilde{t}(r_1) $		0.01	0.00	4.67	0.00	0.00	0.03	0.00	1.42	0.13	0.00
$ t(\hat{\rho}_k) $		0.02	0.00	4.69	0.00	0.00	0.02	0.00	1.26	0.11	0.00
$ \tilde{t}(\hat{\rho}_k) $		0.03	0.00	4.70	0.00	0.00	0.02	0.01	1.45	0.16	0.00
Tests based on model-specific size correction											
$ t(r_1) $		4.76	4.86	4.67	4.71	5.12	5.07	5.05	4.67	5.12	4.87
$ \tilde{t}(r_1) $		4.76	4.86	4.67	4.71	5.12	5.07	5.05	4.67	5.12	4.87
$ t(\hat{\rho}_k) $		4.68	4.62	4.69	5.01	5.25	5.08	5.10	4.67	5.14	4.99
$ \tilde{t}(\hat{\rho}_k) $		4.53	4.85	4.70	4.73	4.92	4.95	4.93	4.69	4.87	4.74
Sample size: $n = 60$		Asymptotic tests and bounds									
$ t(r_1) $		4.20	2.83	51.06	64.44	66.24	2.88	2.92	30.43	30.64	48.45
$ \tilde{t}(r_1) $		4.89	3.22	52.25	65.24	67.27	3.07	3.09	31.20	31.39	49.41
$ t(\hat{\rho}_k) $		4.24	2.81	50.60	63.79	65.73	2.84	2.88	29.91	30.26	47.99
$ \tilde{t}(\hat{\rho}_k) $		4.77	3.05	51.26	64.61	66.54	2.95	3.13	30.81	30.81	48.65
$E_{11}$		0.72	0.91	2.24	0.76	0.00	1.15	1.08	2.77	1.29	0.01
Best bound		1.01	1.21	2.24	0.76	0.00	1.24	1.10	2.77	1.29	0.01
Tests based on Imhof critical values											
$ t(r_1) $		4.99	3.29	52.34	65.41	67.41	3.12	3.12	31.42	31.44	49.51
$ \tilde{t}(r_1) $		5.20	3.48	52.65	65.70	67.62	3.21	3.19	31.69	31.78	49.84
$ t(\hat{\rho}_k) $		5.12	3.34	51.84	64.89	66.66	3.09	3.09	31.01	31.21	48.97
$ \tilde{t}(\hat{\rho}_k) $		4.95	3.16	51.83	65.03	66.99	3.07	3.20	31.24	31.35	49.10
Tests based on global size correction											
$ t(r_1) $		0.00	0.00	5.03	0.00	0.00	0.00	0.00	1.81	0.08	0.00
$ \tilde{t}(r_1) $		0.00	0.00	5.03	0.00	0.00	0.00	0.00	1.81	0.08	0.00
$ t(\hat{\rho}_k) $		0.00	0.00	4.98	0.00	0.00	0.00	0.00	1.86	0.08	0.00
$ \tilde{t}(\hat{\rho}_k) $		0.00	0.00	4.92	0.00	0.00	0.00	0.00	1.83	0.07	0.00
Tests based on model-specific size correction											
$ t(r_1) $		4.61	5.20	5.03	5.01	5.28	4.99	4.93	4.93	5.08	5.13
$ \tilde{t}(r_1) $		4.61	5.20	5.03	5.01	5.28	4.99	4.93	4.93	5.08	5.13
$ t(\hat{\rho}_k) $		4.45	5.04	4.98	5.07	5.07	5.00	4.81	4.93	5.20	5.06
$ \tilde{t}(\hat{\rho}_k) $		4.56	5.18	4.92	4.68	4.74	4.90	4.90	4.98	5.07	5.02

Table 3. Empirical powers of alternative tests for serial dependence at nominal level  $\alpha = 0.05$

$$X_t = 0.2X_t + u_t$$

Sample size: $n = 30$		Asymptotic tests and bounds									
Error distribution ( $v_t$ )		N(0,1)					Cauchy				
Test \ Model		M1	M2	M5	M7	M8	M1	M2	M5	M7	M8
$E_{11}$		4.67	6.83	3.38	19.71	47.23	14.19	14.50	7.13	19.67	44.30
Best bound		5.44	7.27	3.38	19.71	47.23	14.40	14.66	7.13	19.67	44.30
Tests based on global size correction											
$ t(r_1) $		0.11	0.02	7.47	0.15	0.00	0.10	0.13	3.15	0.51	0.00
$ \tilde{t}(r_1) $		0.11	0.02	7.47	0.15	0.00	0.10	0.13	3.15	0.51	0.00
$ t(\hat{\rho}_k) $		0.08	0.02	6.50	0.02	0.00	0.06	0.07	2.45	0.37	0.00
$ \tilde{t}(\hat{\rho}_k) $		0.19	0.07	8.52	0.52	0.00	0.15	0.20	3.56	0.73	0.00
Tests based on model-specific size correction											
$ t(r_1) $		18.47	22.02	7.47	24.52	24.70	16.43	15.35	8.69	13.24	16.69
$ \tilde{t}(r_1) $		18.47	22.02	7.47	24.52	24.70	16.43	15.35	8.69	13.24	16.69
$ t(\hat{\rho}_k) $		12.00	13.43	6.50	19.59	19.16	11.22	10.45	7.41	11.08	13.53
$ \tilde{t}(\hat{\rho}_k) $		17.55	20.60	8.52	24.79	24.63	16.09	15.37	9.08	13.87	17.30
Sample size: $n = 60$		Asymptotic tests and bounds									
$E_{11}$		11.16	14.20	3.23	22.35	47.89	24.65	25.42	7.70	24.62	45.18
Best bound		13.03	15.56	3.23	22.35	47.89	24.95	25.71	7.70	24.62	45.18
Tests based on global size correction											
$ t(r_1) $		0.00	0.00	7.69	0.07	0.00	0.01	0.01	3.01	0.28	0.00
$ \tilde{t}(r_1) $		0.00	0.00	7.69	0.07	0.00	0.01	0.01	3.01	0.28	0.00
$ t(\hat{\rho}_k) $		0.00	0.00	7.36	0.02	0.00	0.01	0.01	2.75	0.22	0.00
$ \tilde{t}(\hat{\rho}_k) $		0.00	0.01	8.27	0.12	0.00	0.01	0.01	3.19	0.29	0.00
Tests based on model-specific size correction											
$ t(r_1) $		32.79	41.35	7.69	24.71	24.91	40.82	40.66	8.94	11.64	17.72
$ \tilde{t}(r_1) $		32.79	41.35	7.69	24.71	24.91	40.82	40.66	8.94	11.64	17.72
$ t(\hat{\rho}_k) $		26.36	33.25	7.36	23.09	22.74	27.10	27.18	8.22	10.88	16.64
$ \tilde{t}(\hat{\rho}_k) $		31.39	40.17	8.27	25.14	25.14	39.30	39.85	9.22	12.05	18.45

Table 4. Empirical powers of alternative tests for serial dependence at nominal level  $\alpha = 0.05$

$$X_t = 0.9X_t + u_t$$

Sample size: $n = 30$		Asymptotic tests and bounds; $n = 30$									
Error distribution ( $v_t$ )		N(0,1)					Cauchy				
Test \ Model		M1	M2	M5	M7	M8	M1	M2	M5	M7	M8
$E_{11}$		98.22	97.89	18.77	83.89	84.49	94.54	94.97	35.42	90.24	89.73
Best bound		98.51	98.08	18.77	84.23	84.88	94.72	95.13	35.45	90.58	89.97
Tests based on global size correction											
$ t(r_1) $		93.19	96.38	39.32	79.25	78.94	93.70	94.52	56.05	88.42	86.34
$ \tilde{t}(r_1) $		93.19	96.38	39.32	79.25	78.94	93.70	94.52	56.05	88.42	86.34
$ t(\hat{\rho}_k) $		80.50	90.34	39.57	71.47	70.86	86.57	87.84	55.08	81.75	80.00
$ \tilde{t}(\hat{\rho}_k) $		85.73	93.08	46.32	73.47	73.24	89.90	91.05	60.90	84.02	81.64
Tests based on model-specific size correction											
$ t(r_1) $		99.66	99.96	39.32	83.81	83.48	98.97	99.20	70.81	92.79	89.47
$ \tilde{t}(r_1) $		99.66	99.96	39.32	83.81	83.48	98.97	99.20	70.81	92.79	89.47
$ t(\hat{\rho}_k) $		98.44	99.69	39.57	77.33	76.97	98.36	98.60	70.71	89.14	85.12
$ \tilde{t}(\hat{\rho}_k) $		98.92	99.86	46.32	78.88	78.62	98.59	98.77	76.99	90.30	86.37
Sample size: $n = 60$		Asymptotic tests and bounds									
$E_{11}$		99.99	100	18.98	86.00	85.48	98.91	99.02	34.67	95.63	90.61
Best bound		99.99	100	18.98	86.28	85.83	98.98	99.04	34.76	95.77	90.84
Tests based on global size correction											
$ t(r_1) $		99.05	99.52	39.25	80.41	79.77	97.88	98.15	53.85	92.80	86.90
$ \tilde{t}(r_1) $		99.05	99.52	39.25	80.41	79.77	97.88	98.15	53.85	92.80	86.90
$ t(\hat{\rho}_k) $		97.08	98.63	39.96	76.35	75.52	96.89	97.04	54.04	90.16	83.86
$ \tilde{t}(\hat{\rho}_k) $		97.75	99.00	42.80	77.01	76.42	97.22	97.45	56.56	90.77	84.40
Tests based on model-specific size correction											
$ t(r_1) $		100	100	39.25	84.79	84.39	99.71	99.67	70.18	96.05	90.04
$ \tilde{t}(r_1) $		100	100	39.25	84.79	84.39	99.71	99.67	70.18	96.05	90.04
$ t(\hat{\rho}_k) $		100	100	39.96	81.49	80.79	99.67	99.58	70.06	94.66	87.73
$ \tilde{t}(\hat{\rho}_k) $		100	100	42.80	82.13	81.45	99.68	99.59	73.25	94.96	88.31

Results on empirical frequencies of type I errors (empirical level) appear in Table 2, while powers for  $\rho = 0.2, 0.9$  appear in tables 3 - 4.<sup>1</sup>

We see from these results that the bounds constitute the only methods that allow one to control size for all the patterns considered. Further, once standard tests are corrected for size, the bounds can lead to substantial power gains. This holds even if the powers of the non-bound procedures are indeed overestimated. The adjustments required to correct the size of the alternative tests are simply too “large” to yield useful tests of the nonparametric hypothesis considered. This shows clearly that the distribution-free bounds presented in this paper can at least provide a useful check on the reliability of serial dependence tests that are not provably distribution-free. We also observed that the tightest exponential  $E_{11} = B_1(y_1, |X|)$  yields the best results in terms of power (for a level of 0.05), with a performance that is very close to one one of the minimum value over all the bounds (which may come supplied by a different bound, depending on the sample).

## 6. Empirical illustration

In this section, we illustrate how the bounds derived above can be used by applying them to U.S. data on interest rates. We will study the autocorrelation structure of the first and second differences of the logarithm of the commercial paper rate [denoted by  $\ln(r_t)$ ] from 1951 to 1983 (quarterly, 132 observations). The source of the data is Balke and Gordon (1986, pp. 789-808).

For these two series, we report in Tables 1 and 2 the usual centered autocorrelations  $\hat{\rho}_k = \sum_{t=1}^{n-k} (X_t - \bar{X})(X_{t+k} - \bar{X}) / \sum_{t=1}^n (X_t - \bar{X})^2$ , where  $\bar{X} = \sum_{t=1}^n X_t / n$ , and the uncentered autocorrelations  $r_k$  defined in (A.2) with  $\mu_t = 0$ , for  $k = 1, \dots, 20$ . Since both series have means very close to zero, there is very little difference between the two sets of autocorrelation coefficients (see also the  $t$ -statistics reported in the tables). Even though we are mostly interested by the minimal upper bound on the  $p$ -value for testing independence, we also report the individual bounds for the sake of comparison (but one would not normally report all this information). The bounds reported are for two-sided tests, *i.e.*, we compute bounds on  $P[|r_k| \geq y \mid |X|] = 2P[r_k \geq |y| \mid |X|]$  at  $y = \hat{r}_k$  (observed value of  $r_k$ ). The upper bounds on  $P[r_k \geq |y| \mid |X|]$  computed are based on the four exponential bounds  $E_{1k} \leq E_{2k} \leq E_{3k} \leq E_{4k}$  from (2.3), the improved Eaton-Pinelis bound  $B_{EP}^*$  and the Eaton-Pinelis bound  $B_{EP}$  from (3.1), Chebyshev bounds based on the exact conditional even moments of  $r_k$ , binomial moments and normal moments as given in (3.4)-(3.5), and the Berry-Esséen-Zolotarev type bound  $BE_U$  given by (4.2). The Chebyshev bound ( $C$ ) based on the exact moments of  $r_k$  is the tightest obtained from the first six even moments ( $p = 2, 4, \dots, 12$ ), the one based on the binomial moments is the best over the first 15 even moments ( $p = 2, 4, \dots, 30$ ), while the normal moment bound is based on (3.5). We also report the Berry-Esséen lower bound obtained from (4.2). When an upper bound exceeds one (which can occur for all bounds considered except  $B_{EP}^*$  and  $B_{EP}$ ), we report 1.0 in the table (since a probability cannot be greater than 1.0). Similarly, when the lower bound is less than zero, we report 0.0 in the table.

From the results in Table 5, we see that the series  $X_t = (1 - B) \ln(r_t) = \ln(r_t) - \ln(r_{t-1})$  exhibits four autocorrelations  $r_k$  (at lags  $k = 1, 2, 6, 7$ ) whose absolute values exceed two asymptotic

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<sup>1</sup>More complete results are available from the authors upon request.

Table 5: U.S. Commercial Paper Interest Rate (logarithm, first differences) :  $X_t = (1 - B) \ln(r_t)$   
Autocorrelations and bounds on p-values for two-sided tests  
Sample : 1951:2-1983:4 (quarterly,  $n = 131$  observations)<sup>a</sup>

$k$	$\hat{\rho}_k$	$r_k$	Exponential bounds				Eaton-type bounds		Chebyshev-type bounds				Berry-Essén $BE_U$	Best upper bound	Type	Lower bound $BE_U$
			$E_1$	$E_2$	$E_3$	$E_4$	$B_{EP}^*$	$B_{EP}$	$C(p^*)$	$CB(p^*)$	$CN$					
1	0.3339	0.3385	0.0124	0.0200	0.0332	0.0347	0.0169	0.0175	0.0100	(12)	0.0235	(8)	0.0243	0.0100*	C	0.0000
2	-0.2105	-0.2023	0.4277	0.4516	0.5053	0.5079	0.3494	0.3502	0.3353	(4)	0.3648	(2)	0.3648	0.3353	C	0.0000
3	-0.0393	-0.0326	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	(2)	1.0000	1.0000		0.2144
4	0.0911	0.0969	1.0000	1.0000	1.0000	1.0000	0.9179	0.9179	0.9179	(2)	0.9179	(2)	0.9179	0.6903	BEU	0.0000
5	-0.0499	-0.0415	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	(2)	1.0000	0.9371	BEU	0.2565
6	-0.2490	-0.2383	0.0314	0.0357	0.0460	0.0478	0.0240	0.0248	0.0246	(10)	0.0327	(8)	0.0338	0.4110	BEP*	0.0000
7	-0.2132	-0.2027	0.0467	0.0499	0.0598	0.0618	0.0320	0.0328	0.0350	(8)	0.0435	(8)	0.0446	0.3674	BEP*	0.0000
8	-0.0174	-0.0086	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	(2)	1.0000	1.0000		0.4774
9	-0.0230	-0.0136	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	(2)	1.0000	1.0000		0.4522
10	-0.1787	-0.1686	0.3146	0.3208	0.3458	0.3489	0.2255	0.2267	0.2307	(4)	0.2446	(4)	0.2460	0.5000	BEP*, C	0.0000
11	-0.1190	-0.1088	0.7822	0.7837	0.7973	0.7993	0.5452	0.5452	0.5452	(2)	0.5452	(2)	0.5452	0.5684	BEP*, C	0.0000
12	-0.0179	-0.0077	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	(2)	1.0000	1.0000		0.4990
13	0.0118	0.0210	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	(2)	1.0000	1.0000		0.2967
14	0.0296	0.0400	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	(2)	1.0000	0.9983	BEU	0.1485
15	0.0788	0.0905	1.0000	1.0000	1.0000	1.0000	0.9427	0.9427	0.9427	(2)	0.9427	(2)	0.9427	0.7598	BEU	0.0000
16	0.1127	0.1228	0.7597	0.7636	0.7867	0.7888	0.5374	0.5374	0.5374	(2)	0.5374	(2)	0.5374	0.6671	BEP*, C	0.0000
17	0.1005	0.1088	0.7276	0.7296	0.7459	0.7481	0.5085	0.5085	0.5085	(2)	0.5085	(2)	0.5085	0.5762	BEP*, C	0.0000
18	-0.0055	0.0025	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	(2)	1.0000	1.0000		0.4941
19	-0.1109	-0.1029	0.6813	0.6830	0.6973	0.6997	0.4761	0.4761	0.4761	(2)	0.4761	(2)	0.4761	0.5297	BEP*, C	0.0000
20	-0.0640	-0.0567	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	(2)	1.0000	0.7679	BEU	0.0312

t-statistic for zero mean = 0.9875.

<sup>a</sup> The p-values reported one for two-sided tests. Each one is obtained by bounding  $P[|r_k| \geq y | X] = 2P[r_k \geq y | X]$  where we take  $y = |\hat{r}_k|$  (the observed value of  $|r_k|$ ). The exponential bounds  $E_1 \leq E_2 \leq E_3 \leq E_4$  are based on Proposition 2.1, the Eaton-type bounds on  $B_{EP} \leq B_{EP}$  on Proposition 3.1, the Chebyshev bounds on Proposition 3.2, and the Berry-Essén bounds on Proposition 4.1.  $C$  is the best Chebyshev bound based on the exact even moments of order  $p = 2, 4, \dots, 12$ ,  $CB$  the best Chebyshev bound based on the centered binomial moments of order  $p = 2, 4, \dots, 30$ , and  $CN$  is based on (3.5); the moment yielding the best bound ( $p^*$ ) is given in parenthesis. Best upper bounds lower than 0.05 have been starred (\*).



Table 6: U.S. Commercial Paper Interest Rate (logarithm, second differences) :  $X_t = (1 - B)^2 \ln(r_t)$   
Autocorrelations and bounds on p-values for two-sided tests  
Sample : 1951:3-1983:4 (quarterly,  $n = 130$  observations)

$k$	$\hat{\rho}_k$	$r_k$	Exponential bounds				Eaton-type bounds		Chebyshev-type bounds			Berry-Essén $BE_U$	Best upper bound	Type	Lower bound $BE_U$
			$E_1$	$E_2$	$E_3$	$E_4$	$B_{EP}^*$	$B_{EP}$	$C(p^*)$	$CB(p^*)$	$CN$				
1	-0.0874	-0.0874	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	0.9820	0.9820	BEU	0.0000
2	-0.5392	-0.5392	0.00002	0.0013	0.0042	0.0046	0.0019	0.0020	0.0006	(12)	0.0030	0.5790	0.00002*	E1	0.0000
3	0.0282	0.0282	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	1.0000	1.0000		0.2340
4	0.2043	0.2044	0.3403	0.3474	0.3749	0.3776	0.2473	0.2483	0.2518	(4)	0.2685	0.5397	0.2473	BEP*	0.0000
5	0.0444	0.0445	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	1.0000	1.0000		0.0592
6	-0.1754	-0.1754	0.2373	0.2449	0.2710	0.2739	0.1708	0.1719	0.1774	(4)	0.1887	0.5024	0.1708	BEP*	0.0000
7	-0.1201	-0.1201	0.5735	0.5773	0.5997	0.6020	0.4165	0.4165	0.4165	(2)	0.4165	0.5697	0.4165	BEP*, C	0.0000
8	0.1448	0.1449	0.3858	0.3899	0.4111	0.4139	0.2750	0.2760	0.2863	(4)	0.3005	0.4902	0.2750	BEP*	0.0000
9	0.1187	0.1187	0.4409	0.4484	0.4790	0.4817	0.3283	0.3292	0.3399	(4)	0.3512	0.5774	0.3283	BEP*	0.0000
10	-0.1560	-0.1560	0.3192	0.3337	0.3729	0.3757	0.2458	0.2469	0.2410	(4)	0.2668	0.6288	0.2410	C	0.0000
11	-0.0318	-0.0318	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	0.9564	0.9564	BEU	0.2093
12	0.0612	0.0610	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	0.9182	0.9182	BEU	0.0000
13	0.0017	0.0017	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	1.0000	1.0000		0.6052
14	-0.0308	-0.0307	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	1.0000	1.0000		0.1379
15	0.0082	0.0082	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	1.0000	1.0000		0.4532
16	0.0364	0.0364	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	1.0000	1.0000		0.1480
17	0.0699	0.0700	1.0000	1.0000	1.0000	1.0000	0.8318	0.8318	0.8318	(2)	0.8318	0.6949	0.6949	BEU	0.0000
18	-0.0022	-0.0022	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	1.0000	1.0000		0.4939
19	-0.1100	-0.1100	0.6430	0.6499	0.6806	0.6830	0.4654	0.4654	0.4654	(2)	0.4654	0.6795	0.4654	BEP*, C	0.0000
20	-0.0295	-0.0295	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	1.0000	(2)	1.0000	1.0000	1.0000		0.2008

t-statistic for zero mean = -0.0790.

standard errors ( $|r_k| \geq 2 / \sqrt{n} = 2 / \sqrt{131} = 0.175$ ). Among these, three ( $k = 1, 6, 7$ ) are clearly significant at level 0.05 under the assumption that  $X_1, \dots, X_n$  have distributions symmetric about zero. It is also of interest to note that the autocorrelations at lags  $k = 3, 5, 8, 9, 12, 13, 14, 18$  are clearly not significant at level 0.05. Depending on cases, the best upper bound is obtained by using either a Chebyshev ( $C$ ), Eaton-type ( $B_{EP}^*$ ) or Berry-Esséen bound.

The autocorrelations for the second differences  $X_t = (1 - B)^2 \ln(r_t)$  in Table ?? exhibit only one autocorrelation (at  $k = 2$ ) whose absolute value is greater than two asymptotic standard errors ( $|r_k| \geq 2 / \sqrt{n} = 2 / \sqrt{130} = 0.175$ ). The nonparametric upper bound on the  $p$ -value for  $|r_2|$  indicates that this is significant even for a level as low as 0.00002; the best upper bound is given here by the exponential bound  $E_1$ . In this case, all the upper bounds (except the Berry-Esséen one) indicate that this is significant at level 0.005. The Berry-Esséen lower bound indicates that the autocorrelations at lags  $k = 5, 12, 13$  are clearly not significant at level 0.05. Overall the second differences of  $\ln(r_t)$  seem to have a simpler autocorrelation structure than the first differences  $(1 - B) \ln(r_t)$ .

## A. Appendix: Proofs

**PROOF OF PROPOSITION 2.1** Let  $Z_{kt} = X_t X_{t+k}$ ,  $t = 1, \dots, n - k$ , and let  $\text{sgn}(x)$  be the sign function :  $\text{sgn}(x) = -1$  if  $x < 0$ , 0 if  $x = 0$ , and 1 if  $x > 0$ . Then we can write

$$r_k = D_k(|X|) \sum_{t=1}^{n-k} w_{kt} S_{kt} = D_k(|X|) R_k \quad (\text{A.1})$$

where  $S_{kt} = \text{sgn}(Z_{kt})$ ,  $t = 1, \dots, n - k$ ,  $R_k = \sum_{t=1}^{n-k} w_{kt} S_{kt}$ , and  $\sum w_{kt}^2 = 1$ . When  $Z_{k1} = \dots = Z_{k,n-k} = 0$ , we have  $r_k = D_k(|X|) = 0$ , so that  $P[r_k \geq y \mid |X|] = 0$ , and the result holds trivially. We now suppose that  $Z_{kt} \neq 0$  for at least one  $t$ . Let  $A_k(|X|) = \{t : |X_t| \neq 0, 1 \leq t \leq n - k\}$  and  $B_k(|X|) = \{t : |X_t X_{t+k}| \neq 0, 1 \leq t \leq n - k\}$ . Clearly,  $t \in B_k(|X|)$  if and only if  $t \in A_k(|X|)$  and  $t + k \in A_k(|X|)$ , and

$$R_k = \sum_{t=1}^{n-k} w_{kt} S_{kt} = \sum_{t \in B_k(|X|)} w_{kt} S_{kt}. \quad (\text{A.2})$$

By the independence of  $X_1, \dots, X_n$  and by the symmetry assumption, the variables in the set  $\{\text{sgn}(X_t) : t \in A_k(|X|)\}$  are independent conditional on  $|X|$ , with  $P[\text{sgn}(X_t) = -1 \mid |X|] = P[\text{sgn}(X_t) = 1 \mid |X|] = 0.5$ . Further, since  $\text{sgn}(Z_{kt}) = \text{sgn}(X_t) \text{sgn}(X_{t+k})$ , it is easy to see that the variables in the set  $\{S_{kt} : t \in B_k(|X|)\}$  are independent conditional on  $|X|$  with

$$P[S_{kt} = -1 \mid |X|] = P[S_{kt} = 1 \mid |X|] = 0.5 ; \quad (\text{A.3})$$

see Dufour (1981). It is clear from (A.1)-(A.3) that the conditional distribution of  $r_k$  given  $|X|$  is symmetric about zero. Further, using Markov's inequality and observing that  $\cosh(w_{kt}z) =$

$\cosh(0) = 1$  for  $t \notin B_k(|X|)$ , we have:

$$\mathbb{P}[R_k \geq y \mid |X|] \leq E[\exp(z R_k \mid |X|)] / \exp(zy) = \prod_{t=1}^{n-k} \cosh(w_{kt}z) / \exp(zy) \quad (\text{A.4})$$

for all  $z \geq 0$  and for all  $y$ . Consequently, for all  $y > 0$ ,

$$\begin{aligned} \mathbb{P}[R_k \geq y \mid |X|] &\leq \inf_{z \geq 0} \left\{ \exp(-zy) \prod_{t=1}^{n-k} \cosh(w_{kt}z) \right\} \leq \exp(-y^2) \prod_{t=1}^{n-k} \cosh(w_{kt}y) \\ &= \exp(-y^2) \prod_{t \in B_k(|X|)} \cosh(w_{kt}y) \leq \exp(-y^2) \left\{ \cosh(y/\sqrt{n_k^*}) \right\}^{n_k^*} \\ &< \exp(-y^2) \left\{ \exp\left[(y/\sqrt{n_k^*})^2/2\right] \right\}^{n_k^*} = \exp(-y^2/2), \end{aligned} \quad (\text{A.4})$$

where the second inequality is obtained by taking  $z = y$  in (A.4), the third one follows from Corollary 1 and Example 2 of Eaton (1970), and the last one is obtained by noting that  $\cosh(x) < \exp(x^2/2)$  for  $x > 0$  [Edelman (1986)]. Inequality (2.3) follows from (A.4) on observing that  $r_k = D_k(|X|) R_k$ .  $\square$

**PROOF OF PROPOSITION 3.1** When  $X_t X_{t+k} = 0$ , for  $t = 1, \dots, n-k$ , we have  $r_k = 0$  and (3.1) clearly holds. When  $X_t X_{t+k} \neq 0$  for some  $t$ , the result follows from (A.1) to (A.3), and then by applying Proposition 1 from Dufour and Hallin (1993) to  $R_k$  in (A.2).  $\square$

**PROOF OF PROPOSITION 3.2** When  $X_t X_{t+k} = 0$ , for  $t = 1, \dots, n-k$ , we have  $r_k = 0$ , and (3.4)–(3.5) clearly hold. Otherwise, the result follows from (A.1) to (A.3), and Proposition 2 in Dufour and Hallin (1992).  $\square$

**PROOF OF PROPOSITION 4.1** The result is immediate from (A.1) to (A.3) and Proposition 3 from Dufour and Hallin (1992).  $\square$

## B. Appendix: Conditional moments of the autocorrelations

The conditional moments  $[Er_k^P \mid |X|]$  in (3.4) can be computed by noting that

$$E(r_k^p \mid |X|) = D_k(|X|)^p E(R_k^p \mid |X|) \quad (\text{B.1})$$

where, provided  $D_k(|X|) \neq 0$  (otherwise,  $r_k = 0$ ),  $E(R_k^2 \mid |X|) = 1$  and, for  $p = 4, 6, \dots, 12$ ,  $E(R_k^p \mid |X|)$  is given by the following formulae : setting  $W_{kp} = \sum_{t=1}^{n-k} w_{kt}^p$ ,

$$E(R_k^4 \mid |X|) = 3 - 2 W_{k4}, \quad (\text{B.2})$$

$$E(R_k^6 \mid |X|) = 15 - 30 W_{k4} + 16 W_{k6}, \quad (\text{B.3})$$

$$E(R_k^8 \mid |X|) = 105 - 420 W_{k4} + 140 W_{k4}^2 + 448 W_{k6} - 272 W_{k8}, \quad (\text{B.4})$$

$$E(R_k^{10} \mid |X|) = 945 - 6300 W_{k4} + 6300 W_{k4}^2 + 10080 W_{k6} - 6720 W_{k6} W_{k4}$$

$$- 12240 W_{k8} + 7936 W_{k,10} , \quad (\text{B.5})$$

$$\begin{aligned} E(R_k^{12} \mid |X|) = & 10395 - 103950 W_{k4} + 207900 W_{k4}^2 - 46200 W_{k4}^3 + 221760 W_{k6} \\ & - 443520 W_{k6} W_{k4} + 118272 W_{k6}^2 - 403920 W_{k8} \\ & + 269280 W_{k8} W_{k4} + 523776 W_{k,10} - 353792 W_{k,12} . \end{aligned} \quad (\text{B.6})$$

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